

Search Notes

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Examiner

Shun Lee

Applicant(s)/Patent under
Reexamination

SENDAI ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
250	252.1	3/15/2006	SL
378	207	3/15/2006	SL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	3/15/2006	SL